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reescale Semiconductor

Technical Data

RF Power Field Effect Transistors

N-Channel Enhancement-Mode Lateral MOSFETs

Designed primarily for large-signal output applications at 2450 MHz. Devices are suitable for use in industrial, medical and scientific applications.

Typical CW Performance at 2450 MHz, V_{DD} = 28 Volts, I_{DQ} = 1200 mA, P_{out} = 140 Watts Power Gain — 13.2 dB Drain Efficiency — 45%

 Capable of Handling 10:1 VSWR, @ 28 Vdc, 2390 MHz, 140 Watts CW **Output Power**

Features

- Characterized with Series Equivalent Large-Signal Impedance Parameters
- Internally Matched for Ease of Use
- Qualified Up to a Maximum of 32 V_{DD} Operation
- Integrated ESD Protection
- In Tape and Reel. R3 Suffix = 250 Units per 56 mm, 13 inch Reel.

Document Number: MRF6S24140H

Rev. 4, 2/2012

MRF6S24140HR3 MRF6S24140HSR3

2450 MHz, 140 W, 28 V CW **LATERAL N-CHANNEL RF POWER MOSFETs**

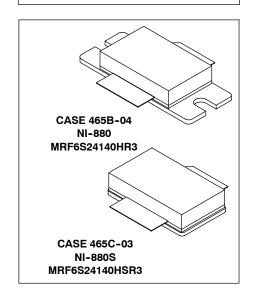


Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
Drain-Source Voltage	V _{DSS}	-0.5, +68	Vdc
Gate-Source Voltage	V _{GS}	-0.5, +12	Vdc
Storage Temperature Range	T _{stg}	- 65 to +150	°C
Case Operating Temperature	T _C	150	°C
Operating Junction Temperature (1,2)	TJ	225	°C

Table 2. Thermal Characteristics

Characteristic	Symbol	Value ^(2,3)	Unit
Thermal Resistance, Junction to Case Case Temperature 82°C, 140 W CW Case Temperature 75°C, 28 W CW	$R_{ heta JC}$	0.29 0.33	°C/W

- 1. Continuous use at maximum temperature will affect MTTF.
- $2. \ \ MTTF\ calculator\ available\ at\ \underline{http://www.freescale.com/rf}.\ Select\ Software\ \&\ Tools/Development\ Tools/Calculators\ to\ access$ MTTF calculators by product.
- 3. Refer to AN1955, Thermal Measurement Methodology of RF Power Amplifiers. Go to http://www.freescale.com/rf. Select Documentation/Application Notes - AN1955.





Table 3. ESD Protection Characteristics

Test Methodology	Class
Human Body Model (per JESD22-A114)	2
Machine Model (per EIA/JESD22-A115)	Α
Charge Device Model (per JESD22-C101)	IV

Table 4. Electrical Characteristics ($T_A = 25^{\circ}C$ unless otherwise noted)

Characteristic	Symbol	Min	Тур	Max	Unit
Off Characteristics			•	•	•
Zero Gate Voltage Drain Leakage Current (V _{DS} = 68 Vdc, V _{GS} = 0 Vdc)	I _{DSS}	_	_	10	μAdc
Zero Gate Voltage Drain Leakage Current (V _{DS} = 28 Vdc, V _{GS} = 0 Vdc)	I _{DSS}	_	_	1	μAdc
Gate-Source Leakage Current (V _{GS} = 5 Vdc, V _{DS} = 0 Vdc)	I _{GSS}	_	_	500	nAdc
On Characteristics			•	•	•
Gate Threshold Voltage (V_{DS} = 10 Vdc, I_{D} = 300 μ Adc)	V _{GS(th)}	1	2	3	Vdc
Gate Quiescent Voltage $(V_{DD} = 28 \text{ Vdc}, I_D = 1300 \text{ mAdc}, Measured in Functional Test})$	V _{GS(Q)}	2	2.8	4	Vdc
Drain-Source On-Voltage (V _{GS} = 10 Vdc, I _D = 3 Adc)	V _{DS(on)}	0.1	0.21	0.3	Vdc
Dynamic Characteristics ⁽¹⁾			•	•	•
Reverse Transfer Capacitance (V _{DS} = 28 Vdc ± 30 mV(rms)ac @ 1 MHz, V _{GS} = 0 Vdc)	C _{rss}	_	2	_	pF

Functional Tests (In Freescale Test Fifxture, 50 ohm system) V_{DD} = 28 Vdc, I_{DQ} = 1300 mA, P_{out} = 28 W Avg., f = 2390 MHz, 2-Carrier W-CDMA, 3.84 MHz Channel Bandwidth Carriers. ACPR measured in 3.84 MHz Channel Bandwidth @ \pm 5 MHz Offset. IM3 measured in 3.84 MHz Bandwidth @ \pm 10 MHz Offset. Input Signal PAR = 8.5 dB @ 0.01% Probability on CCDF.

Power Gain	G _{ps}	13	15.2	17	dB
Drain Efficiency	η_{D}	23	25	_	%
Intermodulation Distortion	IM3	_	-37	-35	dBc
Adjacent Channel Power Ratio	ACPR	_	-40	-38	dBc
Input Return Loss	IRL	_	-15	_	dB

^{1.} Part internally matched both on input and output.



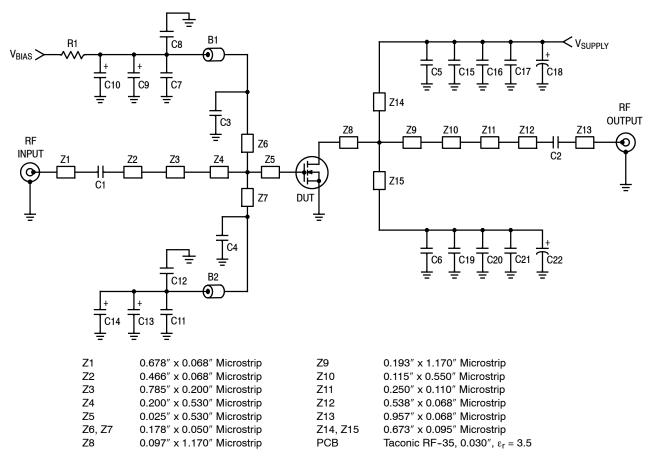
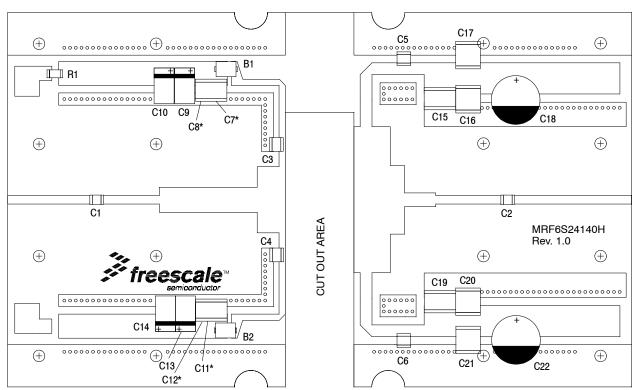


Figure 1. MRF6S24140HR3(SR3) Test Circuit Schematic — 2450 MHz

Table 5. MRF6S24140HR3(SR3) Test Circuit Component Designations and Values

Part	Description	Part Number	Manufacturer
B1, B2	47 Ω , 100 MHz Short Ferrite Beads, Surface Mount	2743019447	Fair-Rite
C1, C2, C3, C4, C5, C6	5.6 pF Chip Capacitors	ATC600B5R6BT500XT	ATC
C7, C11	0.01 μF, 100 V Chip Capacitors	C1825C103J1RAC	Kemet
C8, C12, C15, C19	2.2 μF, 50 V Chip Capacitors	C1825C225J5RAC	Kemet
C9, C13	22 μF, 25 V Tantalum Capacitors	T491D226M025AT	Kemet
C10, C14	47 μF, 16 V Tantalum Capacitors	T491D476K016AT	Kemet
C16, C17, C20, C21	10 μF, 50 V Chip Capacitors	GRM55DR61H106KA88B	Murata
C18, C22	220 μF, 50 V Electrolytic Capacitors	2222-150-95102	Vishay
R1	240 Ω, 1/4 W Chip Resistor	CRC12062400FKEA	Vishay





* Stacked

Figure 2. MRF6S24140HR3(SR3) Test Circuit Component Layout — 2450 MHz



TYPICAL CHARACTERISTICS — 2450 MHz

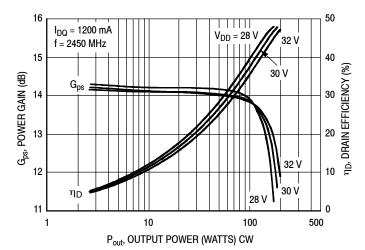


Figure 3. Power Gain and Drain Efficiency versus CW Output Power as a Function of V_{DD}

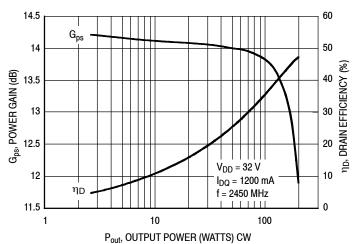


Figure 4. Power Gain and Drain Efficiency versus CW Output Power

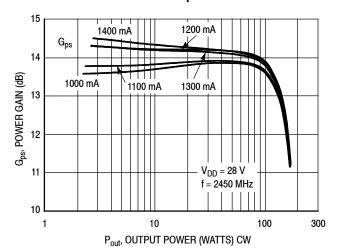
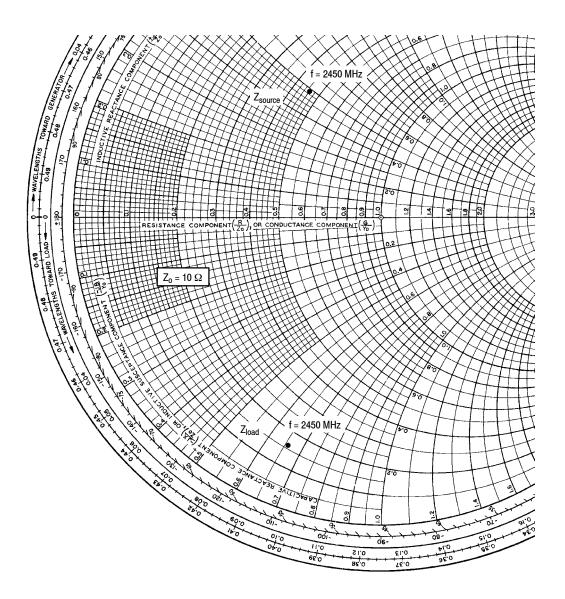


Figure 5. Power Gain and Drain Efficiency versus CW Output Power as a Function of Total I_{DQ}





 V_{DD} = 28 Vdc, I_{DQ} = 1200 mA, P_{out} = 140 W CW

f MHz	$egin{array}{c c} Z_{ ext{source}} & Z_{ ext{load}} \ \Omega & \Omega \end{array}$			
2450	4.55 + j4.9	1.64 - j6.57		

Z_{source} = Test circuit impedance as measured from gate to ground.

 Z_{load} = Test circuit impedance as measured from drain to ground.

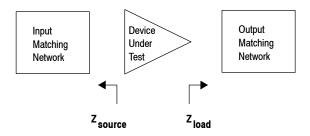
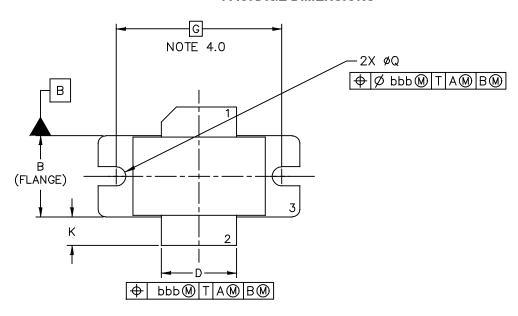
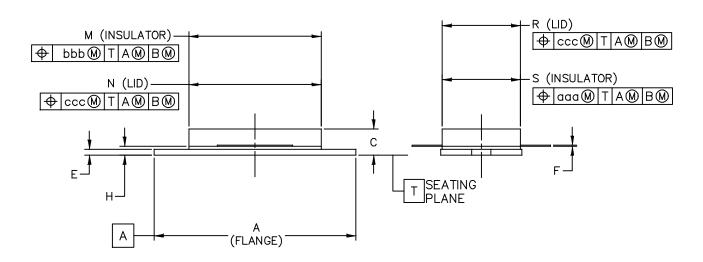


Figure 6. Series Equivalent Source and Load Impedance



PACKAGE DIMENSIONS





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NI-880	CASE NUMBER: 465B-04 26 MAY			
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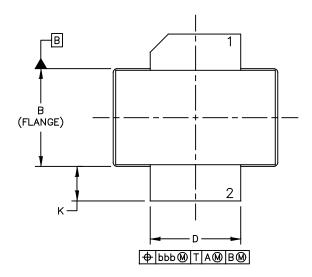


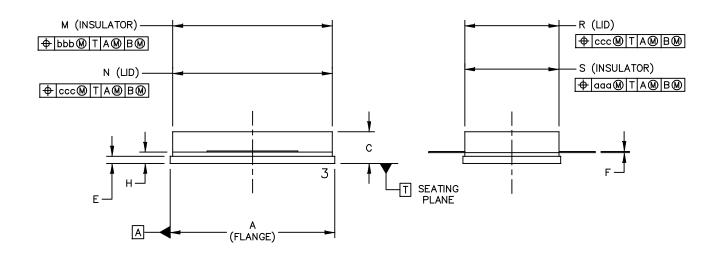
NOTES:

- 1.0 DIMENSIONING AND TOLERANCING PER ANSI Y14.5M-1994.
- 2.0 CONTROLLING DIMENSION: INCH.
- 3.0 DIMENSION H IS MEASURED .030 (0.762) AWAY FROM PACKAGE BODY.
- 4.0 RECOMMENDED BOLT CENTER DIMENSION OF 1.16 (29.57) BASED ON M3 SCREW.

	IN	CH	MIL	LIMETER			INCH		М	ILLIME	TER
DIM	MIN	MAX	MIN	MAX	DIM	MIN		MAX	MIN		MAX
Α	1.335	1.345	33.91	34.16	R	.515	_	.525	13.0	8 –	13.34
В	.535	.545	13.59	13.84	S	.515	_	.525	13.0	8 –	13.34
С	.147	.200	3.73	5.08	aaa	_	.007	_	_	0.178	3 –
D	.495	.505	12.57	12.83	bbb	_	.010	_	_	0.25	4 –
E	.035	.045	0.89	1.14	ccc	_	.015	_	_	0.38	1 —
F	.003	.006	0.08	0.15	_	_	_	_	_	_	_
G	1.100	BSC	27	7.94 BSC	_	_	_	_	_	_	_
H	.057	.067	1.45	1.70	_	_	_	_	_	_	_
K	.175	.205	4.45	5.21	_	_	_	_	_	_	_
М	.872	.888	22.15	22.56	_	_	_	_	_	_	_
N	.871	.889	22.12	22.58	_	_	_	_	_	_	_
Q	ø.118	ø.138	ø3.00	ø3.51	_	_	_	_	_	_	_
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TITLE:	TITLE:					MENT NO	D: 98A	RB18493	С	REV:	F
	NI-880					NUMBER	R: 465	B-04		26	MAY 11
						DARD: NO	DN-JE	EDEC			







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- 3. DIMENSION H IS MEASURED .030 (0.762) AWAY FROM PACKAGE BODY.

		INCH	MILLIN	METER			INCH		М	ILLIMET	ER
DIM	MIN	MAX	MIN	MAX	DIM	MIN		MAX	MIN		MAX
Α	.905	915	22.99 -	- 23.24	aaa	_	.007	_	_	0.178	_
В	.535	545	13.59 -	- 13.84	bbb	_	.010	_	_	0.254	_
С	.147	200	3.73 -	- 5.08	ссс	_	.015	_	_	0.381	_
D	.495	505	12.57 -	- 12.83	-	_	_	_	_	_	_
Ε	.035	045	0.89 -	- 1.14	–	_	_	_	_	_	_
F	.003	006	0.08 -	- 0.15	–	_	_	_	_	_	_
Н	.057	.067	1.45	1.70	-	_	_	_	-	_	_
K	.170	210	4.32 -	- 5.33	-	_	_	_	_	_	_
М	.872	888	22.15 -	- 22.56	-	_	_	_	_	_	_
Ν	.871	889	22.12 -	- 22.58	–	_	_	_	_	_	_
R	.515	525	13.08 -	- 13.34	–	_	_	_	_	_	_
S	.515	525	13.08 -	- 13.34	-	_	_	_	_	_	_

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NI-880S	CASE NU	CASE NUMBER: 465C-03 26 MAY 2				
	STANDAR	D: NON-JEDEC				



PRODUCT DOCUMENTATION, TOOLS AND SOFTWARE

Refer to the following documents to aid your design process.

Application Notes

· AN1955: Thermal Measurement Methodology of RF Power Amplifiers

Engineering Bulletins

• EB212: Using Data Sheet Impedances for RF LDMOS Devices

Software

- Electromigration MTTF Calculator
- RF High Power Model

For Software and Tools, do a Part Number search at http://www.freescale.com, and select the "Part Number" link. Go to the Software & Tools tab on the part's Product Summary page to download the respective tool.

REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description
0	Mar. 2007	Initial Release of Data Sheet
1	Apr. 2008	Operating Junction Temperature increased from 200°C to 225°C in Maximum Ratings table and related "Continuous use at maximum temperature will affect MTTF" footnote added, p. 1 Corrected V _{DS} to V _{DD} in the RF test condition voltage callout for V _{GS(Q)} , and added "Measured in Functional Test", On Characteristics table, p. 2 Updated PCB information to show more specific material details, Fig. 1, Test Circuit Schematic, p. 3
2	Feb. 2009	Modified data sheet to reflect RF Test Reduction described in Product and Process Change Notification number, PCN13232, p. 2
3	Mar. 2010	 Fig. 1, Test Circuit Schematic, Z-list, corrected PCB information to reflect Taconic as manufacturer, p. 3 Fig. 4, Power Gain and Drain Efficiency versus CW Output Power, corrected 28 V to read 32 V, p. 5 Added Electromigration MTTF Calculator and RF High Power Model availability to Product Software, p. 8
4	Feb. 2012	 Table 3, ESD Protection Characteristics, removed the word "Minimum" after the ESD class rating. ESD ratings are characterized during new product development but are not 100% tested during production. ESD ratings provided in the data sheet are intended to be used as a guideline when handling ESD sensitive devices, p. 2. Fig. 6, MTTF versus Junction Temperature removed, p. 5. Refer to the device's MTTF Calculator available at freescale.com/RFpower. Go to Design Resources > Software and Tools. Replaced Case Outline 465B-03, Issue D, with 465B-04, Issue F, p. 1, 7-8. Deleted Style 1 pin note on Sheet 2. On Sheet 2, changed dimension B in mm from 13.6-13.8 to 13.59-13.84, changed dimension H in mm from 1.45-1.7 to 1.45-1.70, changed dimension K in mm from 4.44-5.21 to 4.45-5.21, changed dimension M in mm from 22.15-22.55 to 22.15-22.56, changed dimension N in mm from 19.3-22.6 to 22.12-22.58, changed dimension Q in mm from 3-3.51 to 3.00-3.51, changed dimension R and S in mm from 13.1-13.3 to 13.08-13.34. Replaced Case Outline 465C-02, Issue D, with 465C-03, Issue E, p. 1, 9-10. Deleted Style 1 pin note on Sheet 2. On Sheet 2, changed dimension B in mm from 13.6-13.8 to 13.59-13.84, changed dimension H in mm from 1.45-1.7 to 1.45-1.70, changed dimension M in mm from 22.15-22.55 to 22.15-22.56, changed dimension N in mm from 19.3-22.6 to 22.12-22.58, changed dimension R and S in mm from 13.1-13.3 to 13.08-13.34.



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